

Notice of References Cited	Application/Control No. 10/530,558	Applicant(s)/Patent Under Reexamination TAKEI ET AL.	
	Examiner Lezah W. Roberts	Art Unit 1614	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,174,935	01-2001	Matsunae et al.	523/118
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N	EP 0 173 567	03-1986	EP	Ying	
	O	EP 0 980 682	02-2000	EP	Nakatsuka	
	P					
	Q					
	R					
	S					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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